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| Notice of References Cited | Application/Control No. | Applicant(s)/Patent Under Reexamination |
| | 10/676,714 | WENDLING, PHILIPPE |
| | Examiner | Art Unit |
| | Mike Fatahiyar | 2629 |
| | | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-2001/0006375 A1 | 07-2001 | Tomooka et al. | 345/4 |
| * | B | US-6,847,335 B1 | 01-2005 | Chang et al. | 345/3.1 |
| * | C | US-2001/0004257 A1 | 06-2001 | Nitta et al. | 345/211 |
| * | D | US-6,839,055 B1 | 01-2005 | Nguyen, Khanh T. | 345/204 |
| * | E | US-6,873,307 B2 | 03-2005 | Nitta et al. | 345/3.1 |
| * | F | US-6,049,316 | 04-2000 | Nolan et al. | 345/698 |
| * | G | US-6,483,502 B2 | 11-2002 | Fujiwara, Shuichi | 345/213 |
| * | H | US-6,297,817 B1 | 10-2001 | Larson et al. | 345/213 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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